## Notice of References Cited Application/Control No. 10/594,173 Examiner MARK BLOUIN Applicant(s)/Patent Under Reexamination DENG ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,301,726 B1	11-2007	Suzuki, Shoji	360/97.01
*	В	US-7,245,455 B2	07-2007	Rajakumar, Rajashankar	360/235.8
*	С	US-7,233,460 B2	06-2007	Cha, Ellis T.	360/236
*	D	US-7,123,449 B2	10-2006	Kang, Tae-sik	360/235.8
*	Е	US-7,099,114 B2	08-2006	Kang, Tae-sik	360/235.6
*	F	US-7,057,855 B2	06-2006	Ueno et al.	360/235.7
*	G	US-7,042,678 B2	05-2006	Tsuchiyama et al.	360/235.8
*	Ι	US-7,038,883 B2	05-2006	Tsuchiyama et al.	360/235.6
*	I	US-RE39,004 E	03-2006	Park et al.	360/235.6
*	J	US-6,999,282 B2	02-2006	Rao, Ram Mahan	360/236
*	K	US-6,989,965 B2	01-2006	Mundt et al.	360/235.4
*	L	US-6,937,440 B2	08-2005	Rajakumar et al.	360/236.2
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.